

CoolSiC™ 1200V SiC Trench MOSFET with .XT interconnection technology

Features

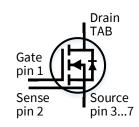
- Very low switching losses
- Short circuit withstand time 3 μs
- Fully controllable dV/dt
- Benchmark gate threshold voltage, V_{GS(th)} = 4.5V
- Robust against parasitic turn on, 0V turn-off gate voltage can be applied
- Robust body diode for hard commutation
- .XT interconnection technology for best-in-class thermal performance
- Package creepage and clearance distance > 6.1mm
- Sense pin for optimized switching performance

Benefits

- Efficiency improvement
- Enabling higher frequency
- Increased power density
- Cooling effort reduction
- Reduction of system complexity and cost

Potential applications

- Drives
- Infrastructure Charger
- Energy generation Solar string inverter and solar optimizer
- Industrial power supplies Industrial UPS













Product validation

Qualified for industrial applications according to the relevant tests of JEDEC 47/20/22

Note: the source and sense pins are not exchangeable, their exchange might lead to malfunction

Table 1 Key Performance and Package Parameters

Туре	$V_{ t DS}$	I _D	$R_{DS(on}$	$T_{\rm vj,max}$	Marking	Package
		$T_C = 25^{\circ}C$, $R_{th(j-c,max)}$	$T_{\rm vj} = 25^{\circ}$ C, $I_{\rm D} = 16$ A, $V_{\rm GS} = 18$ V			
IMBG120R045M1H	1200V	47A	45mΩ	175°C	12M1H045	PG-TO263-7

CoolSiC™ 1200V SiC Trench MOSFET



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Maximum ratings

1 Maximum ratings

For optimum lifetime and reliability, Infineon recommends operating conditions that do not exceed 80% of the maximum ratings stated in this datasheet.

Table 2 Maximum ratings

Parameter	Symbol	Value	Unit
Drain-source voltage, $T_{vj} \ge 25^{\circ}\text{C}$	$V_{ m DSS}$	1200	V
DC drain current for $R_{\text{th(j-c,max)}}$, limited by T_{vjmax} , $V_{\text{GS}} = 18V$,			
<i>T</i> _C = 25°C	I _D	47	Α
$T_{\rm C} = 100$ °C		33	
Pulsed drain current, t_p limited by T_{vjmax} , $V_{GS} = 18V$	I _{D,pulse} ¹	119	А
DC body diode forward current for $R_{\text{th(j-c,max)}}$, limited by T_{vjmax} , $V_{\text{GS}} = 0\text{V}$ $T_{\text{C}} = 25^{\circ}\text{C}$ $T_{\text{C}} = 100^{\circ}\text{C}$	I _{SD}	47 27	А
Pulsed body diode current, t_p limited by $T_{v_{jmax}}$	I _{SD,pulse} ¹	119	А
Gate-source voltage ²			
Max transient voltage, < 1% duty cycle	V_{GS}	-7 23	V
Recommended turn-on gate voltage	$V_{GS,on}$	1518	V
Recommended turn-off gate voltage	$V_{GS,off}$	0	
Short-circuit withstand time			
$V_{DD} = 800V$, $V_{DS,peak} < 1200V$, $V_{GS,on} = 15V$, $T_{j,start} = 25$ °C	t_{SC}	3	μs
Power dissipation, limited by T_{vjmax}			
$T_{\rm C} = 25^{\circ}{\rm C}$	P_{tot}	227	W
$T_{\rm C} = 100$ °C		113	
Virtual junction temperature	T_{vj}	-55175	°C
Storage temperature	$T_{\rm stg}$	-55150	°C
Soldering temperature Reflow soldering (MSL1 according to JEDEC J-STD-020)	T_{sold}	260	°C

¹ verified by design

² **Important note:** The selection of positive and negative gate-source voltages impacts the long-term behavior of the device. The design guidelines described in <u>Application Note AN2018-09</u> must be considered to ensure sound operation of the device over the planned lifetime.

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Thermal resistances

2 Thermal resistances

Table 3

Parameter Symbo	Comple al	Conditions	Value	Value		
	Symbol		min.	typ.	max.	
MOSFET/body diode thermal resistance, junction – case	$R_{th(j-c)}$		-	0.51	0.66	K/W
Thermal resistance, junction – ambient	$R_{th(j-a)}$	leaded	-	-	62	K/W

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Electrical Characteristics

3 Electrical Characteristics

3.1 Static characteristics

Table 4 Static characteristics (at T_{vj} = 25°C, unless otherwise specified)

Parameter	Symbol	Conditions	Value	Value		
			min.	typ.	max.	
Drain-source on-state	$R_{DS(on)}$	$V_{GS} = 18V, I_{D} = 16A,$				
resistance		T _{vj} = 25°C	-	45	63	
		$T_{\rm vj} = 100^{\circ} \rm C$	-	57	-	mΩ
		$T_{\rm vj} = 175^{\circ}{\rm C}$	-	85	-	11122
		$V_{GS} = 15V, I_{D} = 16A,$				
		$T_{\rm vj} = 25^{\circ} \text{C}$	-	60	80	
Body diode forward	V_{SD}	$V_{GS} = 0V$, $I_{SD} = 16A$				
voltage		<i>T</i> _{vj} = 25°C	-	4.1	5.2	V
		$T_{\rm vj} = 100^{\circ} \rm C$	-	4.0	-	V
		$T_{\rm vj} = 175^{\circ}{\rm C}$	-	3.9	-	
Gate-source threshold	$V_{GS(th)}$	(tested after 1 ms pulse at				
voltage		$V_{GS} = 20V$				
		$I_{\rm D} = 7.5 \mathrm{mA}, V_{\rm DS} = V_{\rm GS}$				V
		$T_{\rm vj} = 25^{\circ} C$	3.5	4.5	5.7	
		T _{vj} =175°C	-	3.6	-	
Zero gate voltage drain	I_{DSS}	$V_{GS} = 0V$, $V_{DS} = 1200V$				
current		$T_{\rm vj} = 25^{\circ} \rm C$	-	0.83	190	μΑ
		$T_{\rm vj} = 175^{\circ}{\rm C}$	-	2.6	-	
Gate-source leakage	I _{GSS}	$V_{GS} = 23V, V_{DS} = 0V$	-	-	100	nA
current		$V_{GS} = -7V, V_{DS} = 0V$	-	-	-100	nA
Transconductance	g_{fs}	$V_{\rm DS} = 20 \text{V}, I_{\rm D} = 16 \text{A}$	-	9	-	S
Internal gate resistance	$R_{G,int}$	$f = 1MHz$, $V_{AC} = 25mV$	-	4.5	-	Ω

CoolSiC™ 1200V SiC Trench MOSFET



Electrical Characteristics

3.2 Dynamic characteristics

Table 5 Dynamic characteristics (at $T_{vj} = 25^{\circ}$ C, unless otherwise specified)

Davamatav	Symbol	Conditions	Value	Unit		
Parameter		Conditions	min.	typ.	max.	Unit
Input capacitance	C _{iss}		-	1527	-	
Output capacitance	Coss	$V_{\rm DD} = 800 \text{V}, V_{\rm GS} = 0 \text{V},$ $f = 1 \text{MHz}, V_{\rm AC} = 25 \text{mV}$ $V_{\rm DD} = 800 \text{V}, I_{\rm D} = 16 \text{A},$ $V_{\rm GS} = 0/18 \text{V}, \text{turn-on pulse}$	-	70	-	pF
Reverse capacitance	C_{rss}		-	7.3	-	
C _{oss} stored energy	Eoss		-	29	-	μJ
Total gate charge	Q_{G}		-	46	-	
Gate to source charge	$Q_{GS,pl}$		-	12	-	nC
Gate to drain charge	Q_{GD}		-	9.7	-	

CoolSiC[™] 1200V SiC Trench MOSFET



Electrical Characteristics

3.3 Switching characteristics

Table 6 Switching characteristics, Inductive load ³

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	
MOSFET Characteristics,	<i>T</i> _{vj} = 25°C					
Turn-on delay time	$t_{\sf d(on)}$	$V_{DD} = 800V, I_{D} = 16A,$	-	9.8	-	
Rise time	t _r	$V_{\rm GS} = 0/18 \text{V}, R_{\rm G,ext} = 2\Omega,$	-	12	-	
Turn-off delay time	$t_{\sf d(off)}$	L_{σ} = 40nH,	-	21	-	ns
Fall time	t _f	diode: body diode at V _{GS} = 0V see Fig. E	-	9.4	-	
Turn-on energy	Eon		-	231	-	
Turn-off energy	$E_{ m off}$		-	48	-	μJ
Total switching energy	E_{tot}		-	279	-	
Body Diode Characteristi	ics, <i>T</i> _{vj} = 25°C					
Diode reverse recovery charge	Qrr	$V_{DD} = 800V, I_{SD} = 16A,$ V_{GS} at diode = 0V,	-	200	-	nC
Diode peak reverse recovery current	I _{rrm}	$di_f/dt = 1000A/\mu s$, Q_{rr} includes also Q_c , see Fig. C	-	3.9	-	А

MOSFET Characteristics,	T _{vj} = 175°C					
Turn-on delay time	$t_{\sf d(on)}$	$V_{DD} = 800V, I_{D} = 16A,$	-	9.8	-	
Rise time	t r	$V_{\rm GS} = 0/18 \text{V}, R_{\rm G,ext} = 2 \Omega,$	-	28	-	
Turn-off delay time	$t_{\sf d(off)}$	L_{σ} = 40nH,	-	21	-	ns
Fall time	t _f	diode:	-	9.4	-	
Turn-on energy	Eon	body diode at $V_{GS} = 0V$	-	370	-	
Turn-off energy	$E_{ m off}$	see Fig. E	-	60	-	μJ
Total switching energy	E_{tot}		-	430	-	
Body Diode Characteristi	cs, <i>T</i> _{vj} = 17	5°C				
Diode reverse recovery charge	Qrr	$V_{DD} = 800 \text{V}, I_{SD} = 16 \text{A},$ V_{GS} at diode = 0V,	-	250	-	nC
Diode peak reverse recovery current	I _{rrm}	$di_f/dt = 1000A/μs$, Q_{rr} includes also Q_C , see Fig. C	-	5	-	А

 $^{^3}$ The chip technology was characterized up to 200 kV/ μ s. The measured dV/dt was limited by measurement test setup and package.

Electrical characteristic diagrams 4

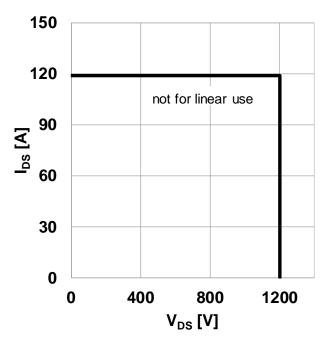
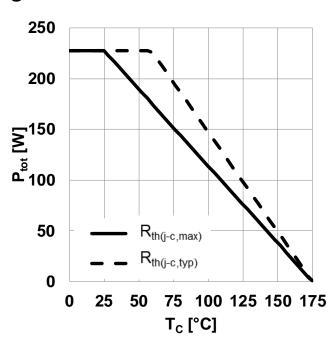


Figure 1 Safe operating area (SOA) $(V_{GS} = 0/18V, T_c = 25^{\circ}C, T_i \le 175^{\circ}C)$



Power dissipation as a function of case Figure 2 temperature limited by bond wire $(P_{\text{tot}} = f(T_{\text{C}}))$

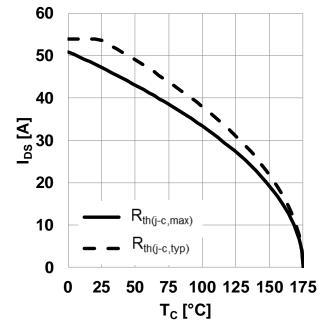
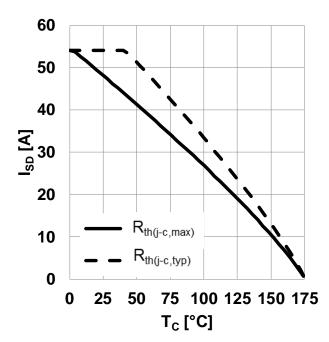
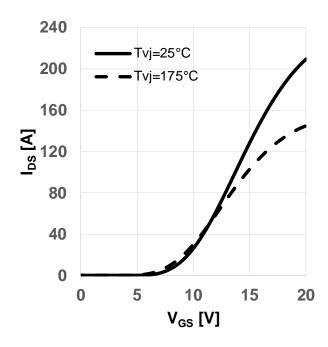


Figure 3 Maximum DC drain to source current as Figure 4 a function of case temperature limited by bond wire $(I_{DS} = f(T_C))$



Maximum source to drain current as a function of case temperature limited by bond wire $(I_{SD} = f(T_C), V_{GS} = 0V)$

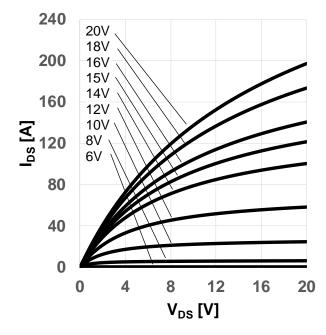




6 5 [V] (#) 89 2 1 0 -50 0 **50** 100 150 T_{vj} [°C]

Figure 5 Typical transfer characteristic $(I_{DS} = f(V_{GS}), V_{DS} = 20V, t_{P} = 20\mu s)$

Figure 6 Typical gate-source threshold voltage as a function of junction temperature $(V_{GS(th)} = f(T_{vj}), I_{DS} = 7.5 \text{ mA}, V_{GS} = V_{DS})$



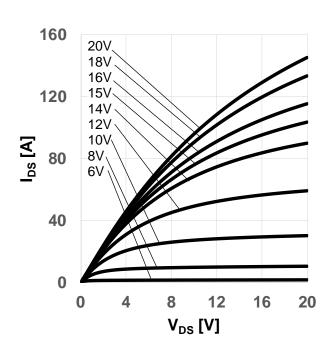
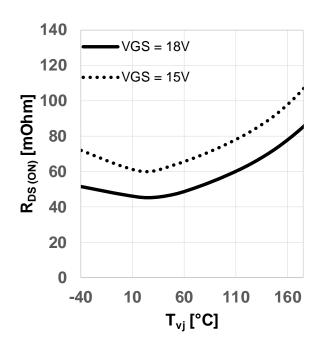


Figure 7 Typical output characteristic, V_{GS} as parameter $(I_{DS} = f(V_{DS}), T_{vi} = 25^{\circ}C, t_{P} = 20\mu s)$

Typical output characteristic, V_{GS} as Figure 8 parameter $(I_{DS} = f(V_{DS}), T_{vi} = 175^{\circ}C, t_{P} = 20 \mu s)$

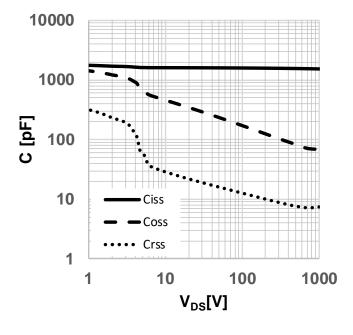


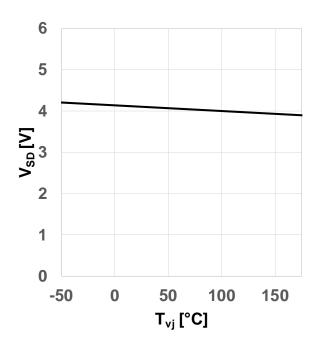


18 16 14 12 V_{GS} [V] 10 8 6 4 2 0 -2 10 20 30 40 **50** 0 Q_G [nC]

Figure 9 Typical on-resistance as a function of junction temperature $(R_{DS(on)} = f(T_{vj}), I_{DS} = 16A)$

Figure 10 Typical gate charge $(V_{GS} = f(Q_G), I_{DS} = 16A, V_{DS} = 800V, turn-on$ pulse)

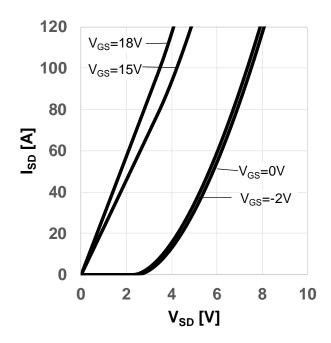




Typical capacitance as a function of Figure 11 drain-source voltage $(C = f(V_{DS}), V_{GS} = 0V, f = 1MHz)$

Typical body diode forward voltage as Figure 12 function of junction temperature $(V_{SD}=f(T_{vi}), V_{GS}=0V, I_{SD}=16A)$





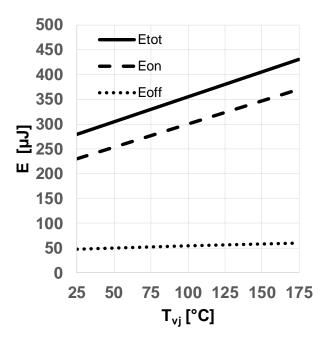
120 $V_{GS}=18V$ 100 $V_{GS}=15V$ 80 60 40 $V_{GS}=0V$ $V_{GS}=-2V$ 20 0 2 6 8 10 0 V_{SD} [V]

Figure 13 Typical body diode forward current as function of forward voltage, V_{GS} as parameter

 $(I_{SD} = f(V_{SD}), T_{vi} = 25^{\circ}C, t_{P} = 20\mu s)$

Typical body diode forward current as Figure 14 function of forward voltage, V_{GS} as parameter

 $(I_{SD} = f(V_{SD}), T_{vj} = 175^{\circ}C, t_{P} = 20 \mu s)$



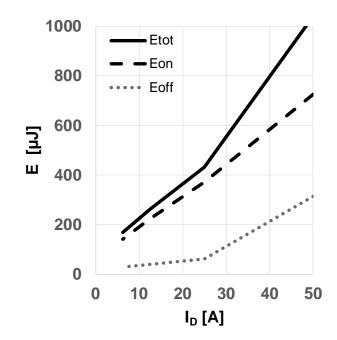


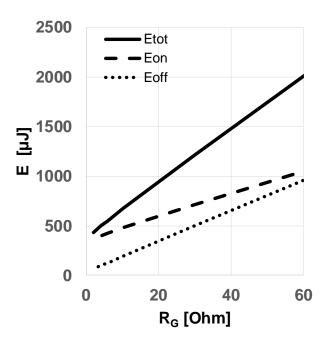
Figure 15 Typical switching energy losses as a function of junction temperature

 $(E = f(T_{vi}), V_{DD} = 800V, V_{GS} = 0V/18V,$ $R_{G,ext} = 2\Omega$, $I_D = 16A$, ind. load, test circuit in Fig. E, diode: body diode at $V_{GS} = 0V$)

Figure 16 Typical switching energy losses as a function of drain-source current

 $(E = f(I_{DS}), V_{DD} = 800V, V_{GS} = 0V/18V,$ $R_{G,ext} = 2\Omega$, $T_{vi} = 175$ °C, ind. load, test circuit in Fig. E, diode: body diode at V_{GS} = 0V)





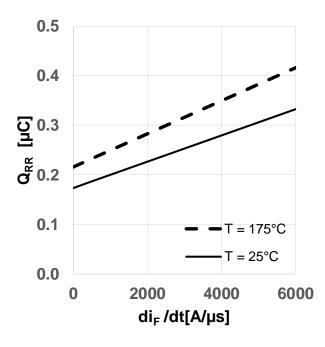
160 td(on) tr td(off) 120 **-**tf Time [ns] 80 40 0 20 40 60 R_G [Ohm]

Figure 17 Typical switching energy losses as a function of gate resistance

 $(E = f(R_{G,ext}), V_{DD} = 800V, V_{GS} = 0V/18V,$ $I_D = 16A$, $T_{vi} = 175$ °C, ind. load, test circuit in Fig. E, diode: body diode at $V_{GS} = 0V$)

Figure 18 Typical switching times as a function of gate resistor

 $(t = f(R_{G,ext}), V_{DD} = 800V, V_{GS} = 0V/18V,$ $I_D = 16A$, $T_{vi} = 175$ °C, ind. load, test circuit in Fig. E, diode: body diode at $V_{GS} = 0V$)



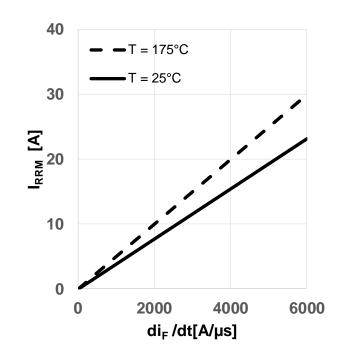


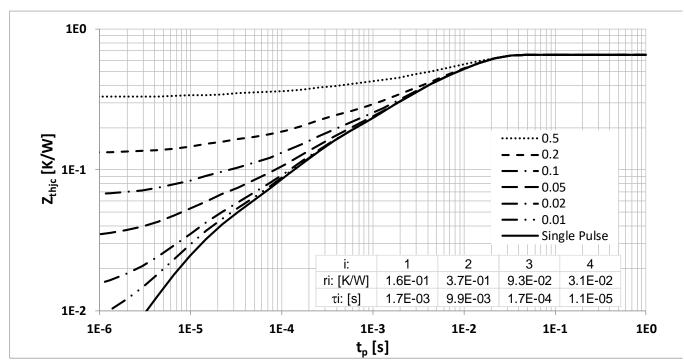
Figure 19 Typical reverse recovery charge as a function of diode current slope

 $(Q_{rr} = f(di_f/dt), V_{DD} = 800V, V_{GS} = 0V/18V,$ I_D = 16A, ind. load, test circuit in Fig.E, body diode at $V_{GS} = 0V$)

Figure 20 Typical reverse recovery current as a function of diode current slope

 $(I_{rrm} = f(di_f/dt), V_{DD} = 800V, V_{GS} = 0V/18V,$ I_D = 16A, ind. load, test circuit in Fig.E, body diode at $V_{GS} = 0V$)





Max. transient thermal resistance (MOSFET/diode) Figure 21

 $(Z_{\text{th}(j-c,max)} = f(t_P), \text{ parameter } D = t_P/T, \text{ thermal equivalent circuit in Fig. D)}$



Package drawing

5 Package drawing

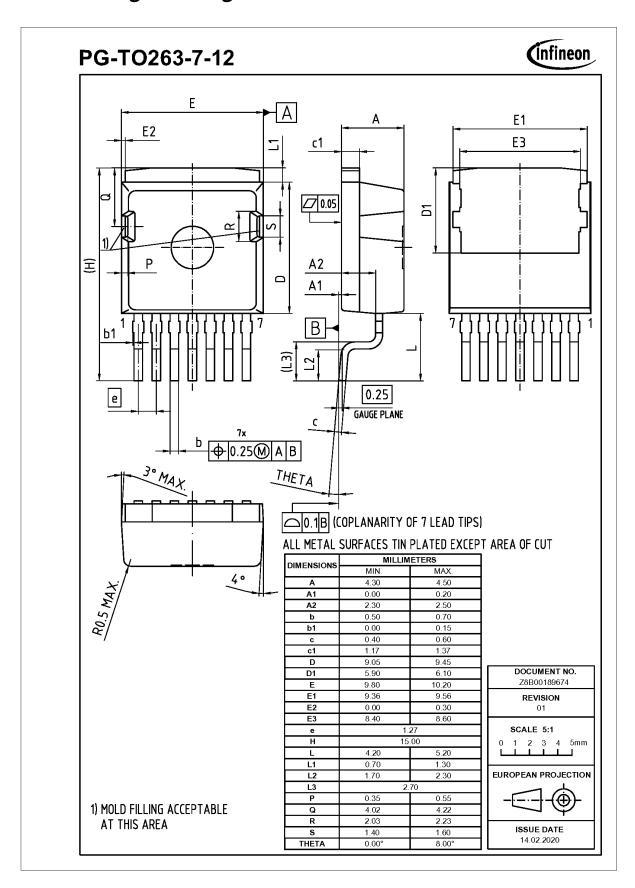


Figure 22 Package drawing

infineon

Test conditions

6 Test conditions

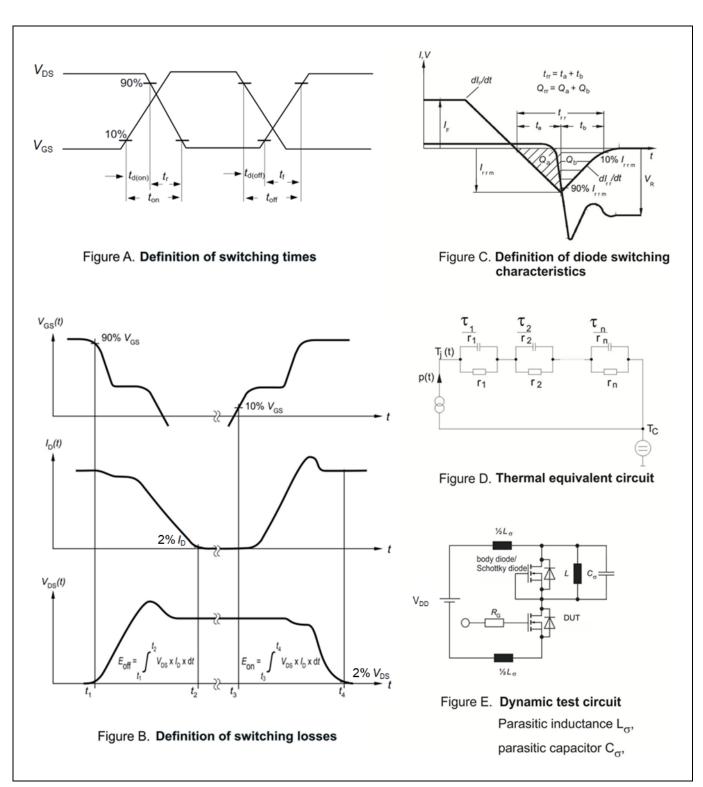


Figure 23 Test conditions

1200V SiC Trench MOSFET



Revision history

Revision history

Document version	Date of release	Description of changes
2.1	2020-09-01	Final Datasheet
2.2	2020-12-11	Correction of circuit symbol on page 1

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